Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/602,621	HIRAGA ET AL.		
Examiner	Art Unit		
Michael J. Hicks	2165		

SEARCHED							
Class	Subclass	Date	Examiner				
707	9	2/2/2006	MIH				
707	104.1	2/2/2006					
707	1	2/2/2006					
	1.0.00						

INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			

SEARCH (INCLUDING SEAR)
		DATE	EXMR
Patent Database Search - East		2/2/2006	MIH
NPL Search - ACM		2/2/2006	
Internet Search - Google Scholar		2/2/2006	
Consulted with Examiner Apu Mofi	Z	2/2/2006	
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